# Statistics 210A Lecture 18 Notes

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# 1 Hypothesis Tests for Gaussian Models

#### 1.1 Recap: hypothesis testing with nuisance parameters

Last time, we discussed hypothesis testing with nuisance parameters. If we have an exponential family  $X \sim e^{\theta T(x) + \lambda^{\top} U(x) - A(\theta, \lambda)} h(x)$  with the one-sided test  $H_0: \theta \leq \theta_0$  vs  $H_1: \theta > \theta_0$ , then the UMPU test rejects for conditionally large  $T \mid U$ . If we have the two-sided test  $H_0: \theta = \theta_0$  vs  $H_1: \theta \neq \theta_0$ , the UMPU test rejects for conditionally extreme  $T \mid U$ . Here,  $P_{\theta}(T \mid U)$  depends only on  $\theta$  (U is sufficient after fixing  $\theta$ ).

We saw the nonparametric test where if  $X_i \stackrel{\text{iid}}{\sim} P$ ,  $Y_i \stackrel{\text{iid}}{\sim} Q$ , then we can test  $H_0 : P = Q$ vs  $H_1 : P \neq Q$  by conditioning on the pooled order statistics. There are various choices of test statistics to use for permutation tests with various properties.

# 1.2 Distributions related to Gaussians

**Example 1.1** ( $\chi^2$  distribution). If  $Z_1, \ldots, Z_d \stackrel{\text{iid}}{\sim} N(0, 1)$ , then

$$V = \sum_{i=1}^{d} Z_i^2 \sim \chi_d^2 = \text{Gamma}(d/2, 2)$$

with

$$\mathbb{E}[V] = d, \qquad \operatorname{Var}(V) = 2d.$$

Note that the standard deviation grows slower than the mean, so as  $d \to \infty$ ,

$$\frac{V}{d} \xrightarrow{p} 1.$$

That is,

$$\mathbb{P}(|\frac{V}{d} - 1| \ge \varepsilon) \to 0$$

for all  $\varepsilon > 0$ . This is what we would expect from the law of large numbers. The central limit theorem tells us that  $V \approx N(d, 2d)$  because  $\sqrt{d}(\frac{V}{d} - 1) \xrightarrow{d} N(0, 2)$ .

**Example 1.2** (*t*-distribution). If  $Z \sim N(0,1)$  and  $V \sim \chi_d^2$  with  $Z \amalg V$ , then

$$\frac{Z}{\sqrt{V}/d} \sim t_d,$$

the **Student's** *T*-distribution, where  $t_d \approx N(0, 1)$  for large *d*.

**Example 1.3** (*F*-distribution). If  $V_1 \sim \chi^2_{d_1}$  and  $V_2 \sim X^2_{d_2}$  with  $V_1 \amalg V_2$ , then

$$\frac{V_1/d_1}{V_2/d_2} \sim F_{d_1, d_2}$$

the *F*-distribution, which has 2 degrees of freedom.  $F_{d_1,d_2} \approx \chi^2_{d_1}$  if  $d_2 \to \infty$ . If  $t \sim t_d$ , then

$$T^2 \sim \frac{Z^2}{V/d} \sim F_{1,d}$$

**Example 1.4.** If  $Z \sim N_d(\mu, \Sigma)$  with  $A \in \mathbb{R}^{k \times d}$  and  $b \in \mathbb{R}^k$ , then

$$AZ + b \sim N(A\mu + b, A\Sigma A^{\top}).$$

#### **1.3** Analysis of the one-sample *t*-test

We saw earlier that if  $X_1, \ldots, X_n \stackrel{\text{iid}}{\sim} N(\mu, \sigma^2)$  with both  $\mu \in \mathbb{R}$  and  $\sigma^2 > 0$  unknown and we test  $H_0: \mu = 0$  vs  $H_1: \mu \neq 0$ , then the UMPU test says to reject for extreme  $\overline{X}$  given  $||X||^2$ . We could also say to reject for large  $|\overline{X}|/||X||$ ; this gets rid of the conditioning given  $||X||^2$ , since under the null,  $|\overline{X}|/||X|| \amalg ||X||^2$ . Equivalently, we can reject for large values of

$$\frac{n\overline{X}}{\|X\|^2 - n\overline{X}^2} = \frac{n\overline{X}^2 / \|X\|^2}{1 - \overline{X}^2 / \|X\|^2}$$

If we didn't want to square this, we could equivalently reject for extreme

$$\frac{\sqrt{n}\overline{X}}{\sqrt{S}^2}, \stackrel{\mathrm{H}_0}{\sim} t_{n-1},$$

where  $S^2 = \frac{1}{n-1} \sum_{i=1}^n (X_i - \overline{X})^2$ . This has a *T*-distirbution because

$$S^2 = \frac{1}{n-1} \|\operatorname{Proj}_{\mathbf{1}_n}^{\perp} X\|^2 \sim \sigma^2 \chi_{n-1}.$$

Here is a picture for n = 2:

What's happening geometrically is that

$$\frac{n\overline{X}}{S^2} \sim F_{1,n-1}$$

is a ratio of squared magnitudes in different directions. If  $\mu = 0$ , then no direction should be special. Let's make this more precise with linear algebra.

Here is a change of basis: Let

$$Q = \begin{bmatrix} | & & | \\ q_1 & \cdots & q_n \\ | & & | \end{bmatrix} = \begin{bmatrix} | & \\ q_1 & Q_r \\ | & \end{bmatrix}$$

with  $q_1 = \frac{1}{\sqrt{n}} \mathbf{1}_n$  and  $q_2, \ldots, q_n$  completing this to an orthonormal basis. Then  $Q^{\top}Q = QQ^{\top} = I_n$ , and  $X \sim N_n(\mu \mathbf{1}_n, \sigma^2 I_n)$ . Let

$$Z = Q^{\top} X = \begin{bmatrix} q_1^{\top} X \\ Q_r^{\top} X \end{bmatrix} = \begin{bmatrix} \sqrt{n} \overline{X} \\ Q_r^{\top} X \end{bmatrix}.$$

Then

$$Q^{\top}X \sim N_n \left( \begin{bmatrix} \sqrt{n}\mu \\ 0 \\ \vdots \\ 0 \end{bmatrix}, \sigma^2 I_n \right),$$

$$||Q_r^{\top}X||^2 = ||Q^{\top}X||^2 - n\overline{X}^2 = ||X||^2 - n\overline{X}^2 = (n-1)S^2.$$

This tells us that

$$Q_r^\top X \sim N_{n-1}(0, \sigma^2 I_{n-1}).$$

Here, we have

$$(n-1)S^2 \sim \sigma^2 \chi^2_{n-1}, \qquad \sqrt{nX} \sim N(\sqrt{n\mu}, \sigma^2).$$

## 1.4 Canonical linear model

Assume

$$Z = \begin{bmatrix} Z_0 \\ Z_1 \\ Z_r \end{bmatrix} \sim N_n \left( \begin{bmatrix} \mu_0 \\ \mu_1 \\ \mu_r \end{bmatrix}, \sigma^2 I_n \right)$$

where  $Z_i$  has dimension  $d_i$  with  $n - d_0 - d_1 = d_r$ . Here,  $\mu_0 \in \mathbb{R}^{d_0}$ ,  $\mu_1 \in \mathbb{R}^{d_1}$ ,  $\mu_r \in \mathbb{R}^{d_r}$ . We want to test  $H_0: \mu_1 = 0$  vs  $H_1: \mu_1 \neq 0$ .

This is an exponential family, with

$$p(z) \propto e^{\frac{\mu_1^{\top}}{\sigma^2}Z_1 + \frac{\mu_0^{\top}}{\sigma^2}Z_0 - \frac{1}{2\sigma^2}||z||^2}h(z).$$

We want to condition on (i.e. ignore) the nuisance parameter  $Z_0$ .

• If  $\sigma^2$  is known and  $d_1 = 1$ , then the UMPU test rejects for large/small/extreme values of

$$\frac{Z_1}{\sigma} \stackrel{H_0}{\sim} N(0,1), \qquad (Z\text{-test}).$$

• For known  $\sigma^2$  and  $d_1 \ge 1$ , reject for large values of

$$\frac{|Z_1|||^2}{\sigma^2} \stackrel{H_0}{\sim} \chi^2_{d_1} \qquad (\chi^2 \text{-test}^1).$$

• For  $d_1 = 1$  and unknown  $\sigma^2$ , condition on  $Z_0$ ,  $||Z||^2 = ||Z_0||^2 + Z_1^2 + ||Z_r||^2$ . We reject for conditionally large/small/extreme  $Z_1$ , which is the same as conditioning on extreme values of  $\frac{Z_1}{\sqrt{Z_1^2} + ||Z_r||^2}$ . This is equivalent to rejecting for extreme values of

$$\frac{Z_1}{\sqrt{\|Z_1\|^2}/d_1} \stackrel{H_0}{\sim} t_{d_1} \qquad (t\text{-test}).$$

• If  $d_1 \ge 1$  and  $\sigma^2$  is unknown, condition on  $Z_0, ||Z_1||^2 + ||Z_r||^2$ . Reject for large

$$\frac{\|Z_1\|^2/d_1}{\|Z_r\|^2/d_r} \stackrel{H_0}{\sim} F_{d_1,d_r} \qquad (F\text{-test})$$

 $\mathbf{SO}$ 

<sup>&</sup>lt;sup>1</sup>There are a number of hypothesis tests referred to as a " $\chi^2$ -test."

Remark 1.1. This is related to the Beta distribution.

$$||X_1||^2 \sim \sigma^2 \operatorname{Gamma}(d_1/2, 2\sigma^2)$$

 $\quad \text{and} \quad$ 

$$||Z_r||^2 \sim \sigma^2 \chi_{d_r}^2 = \operatorname{Gamma}(d_r/2, 2\sigma^2).$$

 $\mathbf{SO}$ 

$$\frac{\|Z_1\|^2}{\|Z_1\|^2 + \|Z_r\|^2} \sim \text{Beta}(d_1/2, d_r/2)$$

More generally, if  $U \sim \text{Beta}(d_1/2, d_r/2)$ , then

$$\frac{U/d_1}{(1-U)/d_r} \sim F_{d_{1,i},d_2}.$$

The normalized residual vector is

$$\frac{1}{d_r} \|Z_r\|^2 \sim \frac{\sigma^2}{d_r} \chi_{d_r}^2 \approx \sigma^2.$$

If we write

$$\widehat{\sigma}^2 = \frac{\|Z_r\|^2}{d_r},$$

then the t-statistic is

and the F-statistic is

$$\frac{1}{d_1} \frac{\|Z_1\|^2}{\widehat{\sigma}^2}.$$

 $\frac{Z_1}{\widehat{\sigma}},$ 

This is a solution to a problem presented in a nice form. Next time, we will talk about how to use a change of basis to solve more general Gaussian model problems.